

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. ASA-994-03	SERIAL NO.
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		APPLICANT Y. KANNO et al	
		FILING DATE 06/27/03	GROUP 2818

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
P	AA	4,803,664	02/07/89	Itoh		
	AB	4,879,682	11/07/89	Engles		
	AC	3,593,037	03/1970	Hoff, Jr.		
	AD	3,706,079	09/1971	Vadasz et al		
	AE	4,893,278	01/1990	Ito		
	AF	6,016,268	01/2000	Worley		
	AG	6,219,277	04/2001	Devin et al		
	AH	3,706,891	12/1972	Donofrio et al		
	AI	4,084,108	04/1978	Fujimoto		
	AJ	4,945,393	07/1990	Beltram et al		
Q	AK	5,396,452	03/1995	Wahlstrom		

FOREIGN PATENT DOCUMENTS

* EXAMINER INITIAL	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO	
						YES	NO
P	AL	11-134866	05/21/99	Japan (with English Abstract)			<input type="checkbox"/> <input type="checkbox"/>
	AM						<input type="checkbox"/> <input type="checkbox"/>
	AN						<input type="checkbox"/> <input type="checkbox"/>
	AO						<input type="checkbox"/> <input type="checkbox"/>
	AP						<input type="checkbox"/> <input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

Q	AR	K. Ito, "Very Large Scale Integration Memory", Baifukan Co., Ltd., 1994, pp. 12-17.
	AS	
	AT	

EXAMINER <i>Seo Anuwong</i>	DATE CONSIDERED <i>3/07</i>
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form next communication to applicant.

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<p>P</p> <p>P</p> <p>AC</p> <p>AD</p> <p>AE</p> <p>AF</p> <p>AG</p> <p>AH</p> <p>AI</p> <p>AJ</p> <p>AK</p>	AA	5,656,528	08/1997	Wahlstrom			
	AB	6,519,195	02/2003	Kanno et al			
FOREIGN PATENT DOCUMENTS							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO YES NO	
<p>AL</p> <p>AM</p> <p>AN</p> <p>AO</p> <p>AP</p>	AL					<input type="checkbox"/>	<input type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>							
<p>AR</p> <p>AS</p> <p>AT</p>							
EXAMINER <i>Gene Aubrey</i>				DATE CONSIDERED <i>3/07</i>			
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